## Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10502280	MYKA ET AL.

Examiner Wen-Tai Lin Reexamination
MYKA ET AL.

Art Unit
2454

	SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES				
Search Notes	Date	Examiner		
Google Search (for Dallas Semiconductor and Tocuh Memory)	2/25/08	WL		
Text search on EAST (See printout)	6/9/09	WL		

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	

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